

Features

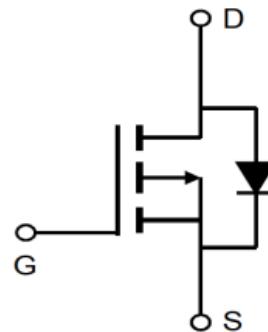
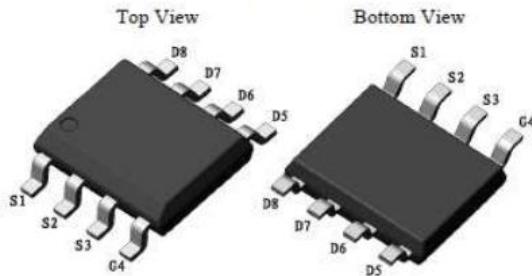
- Uses CRM advanced Trench technology
- Extremely low on-resistance $R_{DS(on)}$
- Excellent $Q_g \times R_{DS(on)}$ product(FOM)
- Qualified according to JEDEC criteria

Product Summary

V_{DS}	-60V
$R_{DS(on)}$ typ.	24mΩ
I_D	-11A

100% DVDS Tested
100% Avalanche Tested
Applications

- Motor control and drive
- Electrical tools
- Lithium battery protection


Package Marking and Ordering Information

Part #	Marking	Package	Packing	Reel Size	Tape Width	Qty
CRTE280P06L2-G	T280P06L2	SOP8	Reel	N/A	N/A	2500pcs

Absolute Maximum Ratings

Parameter	Symbol	Value	Unit
Drain-source voltage	V_{DS}	-60	V
Continuous drain current $T_L = 25^\circ\text{C}$ $T_L = 100^\circ\text{C}$	I_D	-11 -7.0	A
Pulsed drain current ($T_L = 25^\circ\text{C}$, t_p limited by $T_{j\max}$)	I_D pulse	-44	A
Avalanche energy, single pulse ($L=0.5\text{mH}$)	E_{AS}	150	mJ
Gate-Source voltage	V_{GS}	± 18	V
Power dissipation ($T_L = 25^\circ\text{C}$)	P_{tot}	5.0	W
Operating junction and storage temperature	T_j , T_{stg}	-55...+150	°C
Soldering temperature, wave soldering only allowed at leads (1.6mm from case for 10s)	T_{sold}	260	°C

Thermal Resistance

Parameter	Symbol	Typ	Max	Unit
Thermal resistance, junction – ambient(min. footprint)	R _{thJL}	-	25	°C/W

Electrical Characteristic (at T_j = 25 °C, unless otherwise specified)

Parameter	Symbol	Value			Unit	Test Condition
		min.	typ.	max.		

Static Characteristic

Drain-source breakdown voltage	BV _{DSS}	-60	-	-	V	V _{GS} =0V, I _D =-250uA
Gate threshold voltage	V _{GS(th)}	-1	-1.5	-2.5	V	V _{DS} =V _{GS} , I _D =-250uA
Zero gate voltage drain current	I _{DSS}	-	-	-1	μA	V _{DS} =-60V, V _{GS} =0V T _j =25°C T _j =150°C
-	-	-	-100	-	-	
Gate-source leakage current	I _{GSS}	-	-	±100	nA	V _{GS} =±18V, V _{DS} =0V
Drain-source on-state resistance	R _{DS(on)}	-	24	28.0	mΩ	T _j =25°C V _{GS} =-10V, I _D =-1.9A
-	-	27	40.0	-	-	V _{GS} =-4.5V, I _D =-1.9A
Transconductance	g _{fs}		64.85		S	V _{DS} =-5V, I _D =-8A

Dynamic Characteristic

Input Capacitance	C _{iss}	-	3680	-	pF	V _{GS} =0V, V _{DS} =-30V f=1MHz
Output Capacitance	C _{oss}	-	151	-		
Reverse Transfer Capacitance	C _{rss}	-	117	-		
Gate Total Charge	Q _g	-	62.7	-	nC	V _{GS} =-10V, V _{DS} =-30V ID=-8A
Gate-Source charge	Q _{gs}	-	8.2	-		
Gate-Drain charge	Q _{gd}	-	10.2	-		
Turn-on delay time	t _{d(on)}	-	14.2	-	ns	V _{GS} =-10V, V _{DS} =-30V RG=3.0Ω, ID=-8A
Rise time	t _r	-	6.6	-		
Turn-off delay time	t _{d(off)}	-	118	-		
Fall time	t _f	-	70	-		
Gate resistance	R _G	-	7.1	-	Ω	V _{GS} =0V, V _{DS} =0V f=1MHz

Body Diode Characteristic

Parameter	Symbol	Value			Unit	Test Condition
		min.	typ.	max.		
Body Diode Forward Voltage	V _{SD}	-	-	-1.2	V	V _{GS} =0V, I _{SD} =-8A
Body Diode Continuous Forward Current	I _S	-	-	-11	A	T _L = 25°C
Body Diode Reverse Recovery Time	t _{rr}	-	29.38	-	ns	I _F =-8A, dI/dt=100A/μs
Body Diode Reverse Recovery Charge	Q _{rr}	-	30.19	-	nC	

a1: Repetitive rating; pulse width limited by maximum junction temperature

Typical Performance Characteristics

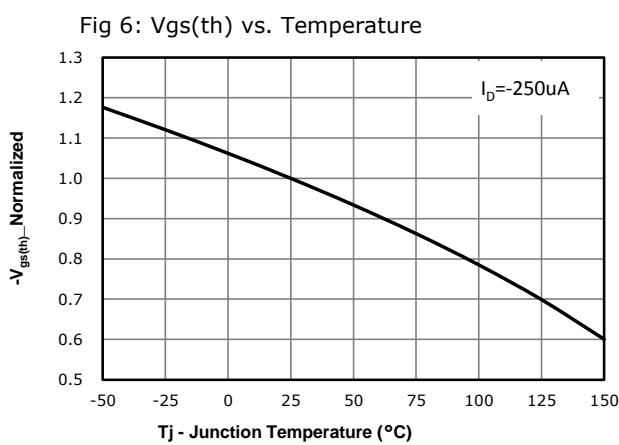
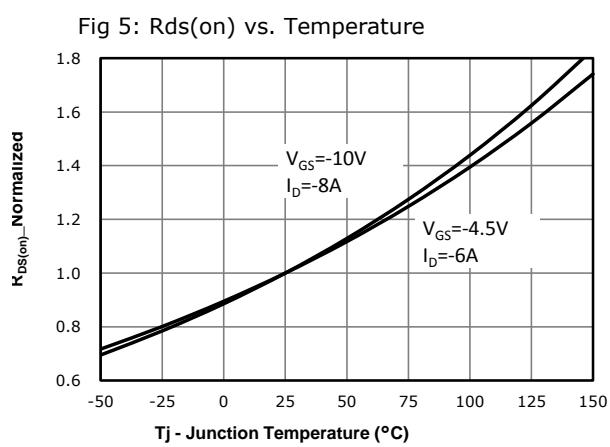
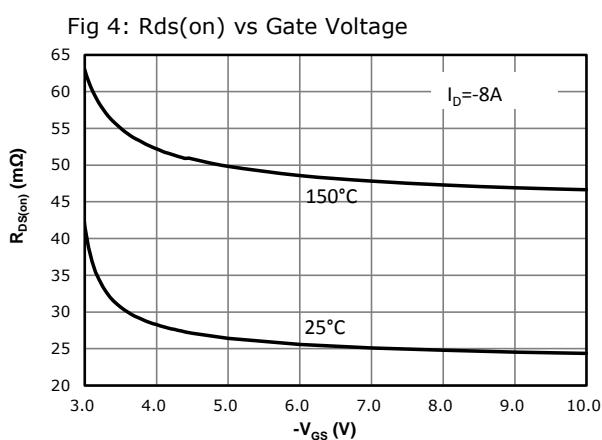
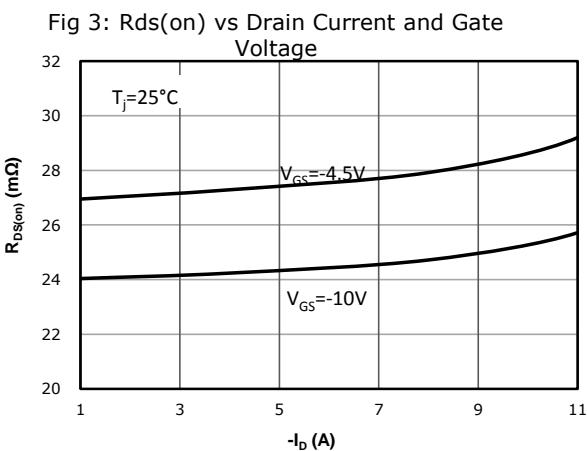
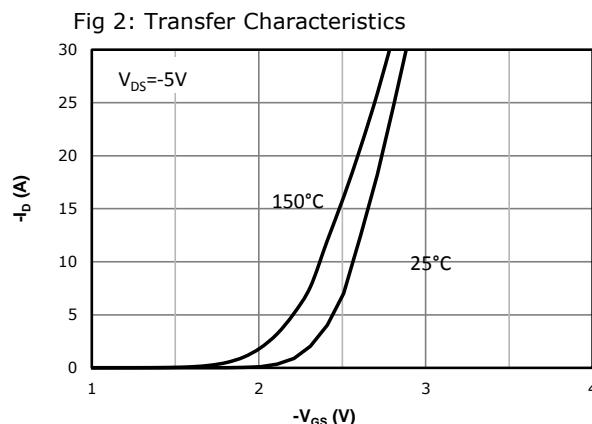
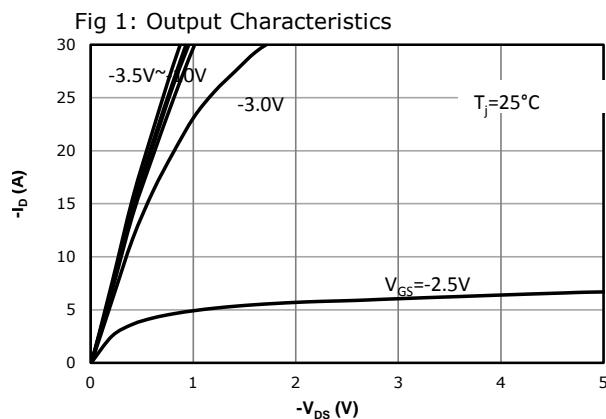


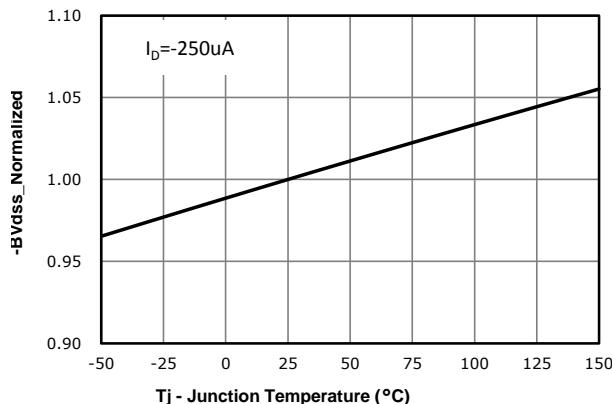
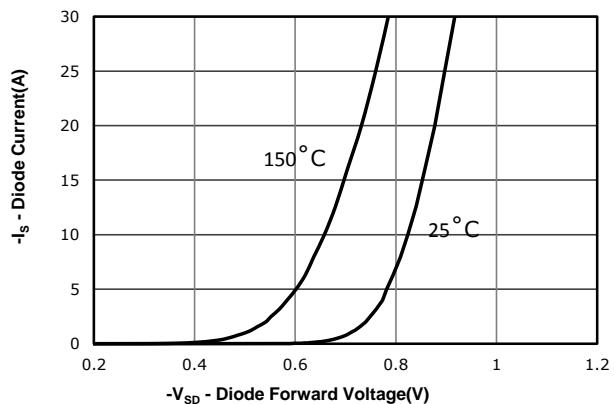
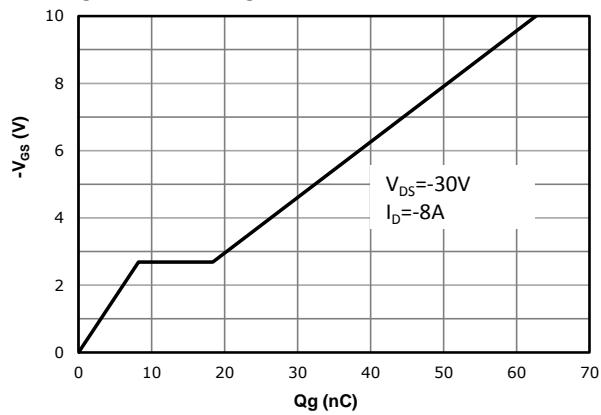
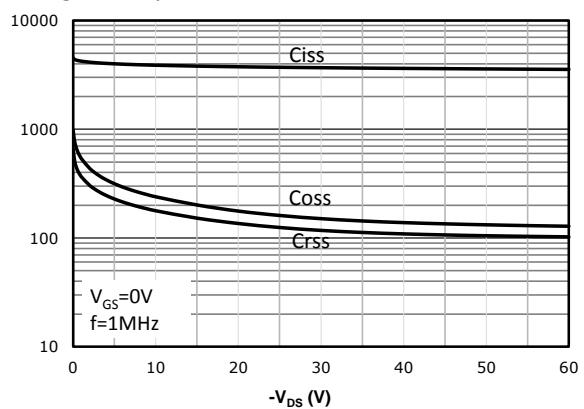
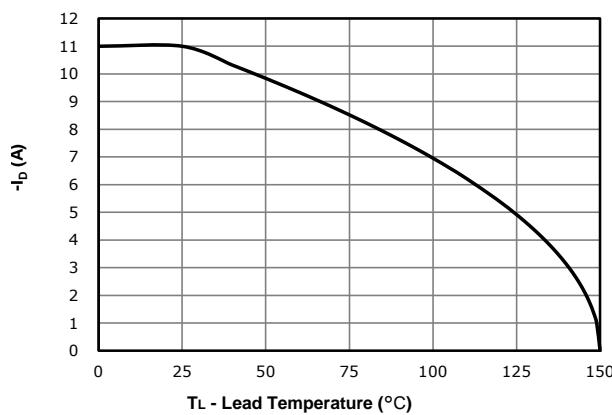
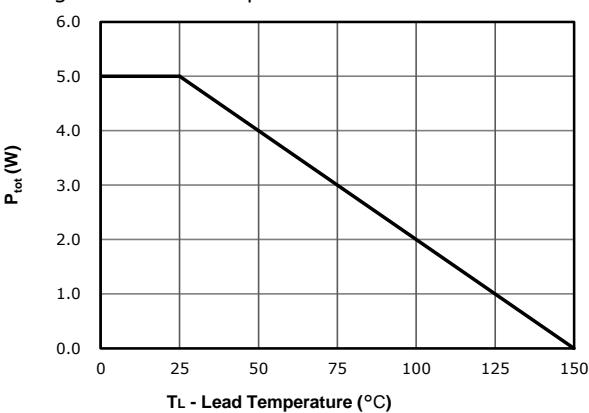
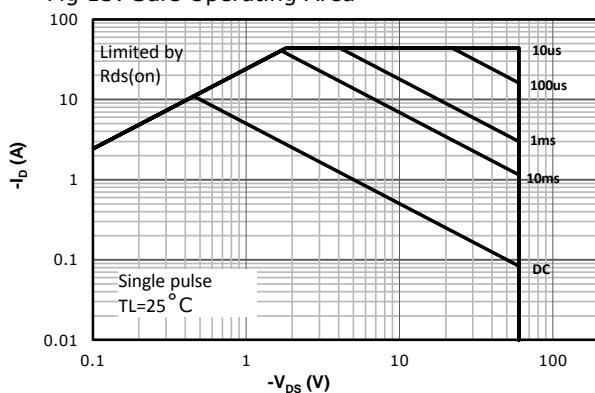
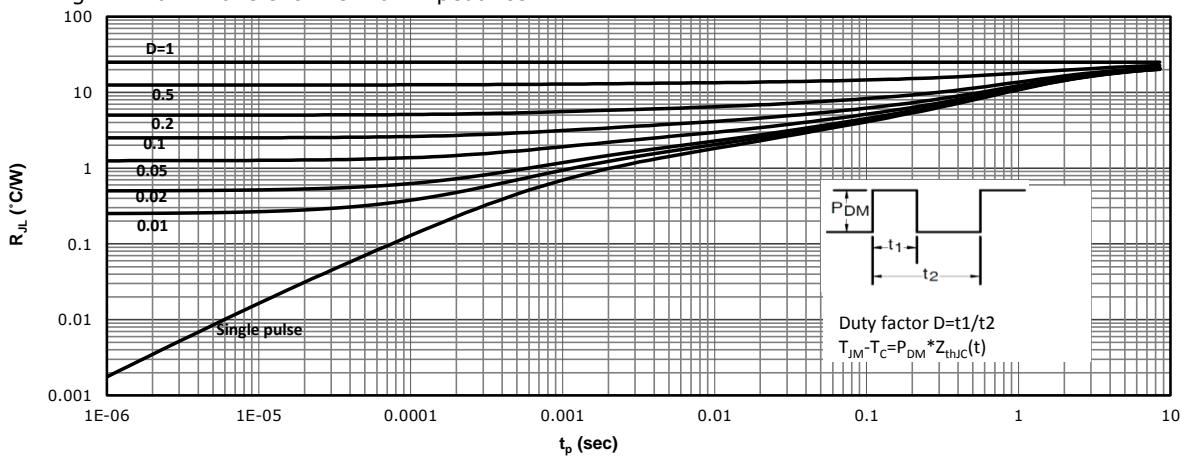
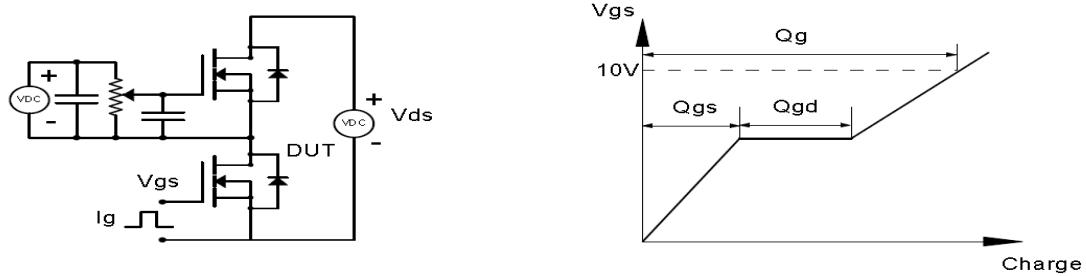
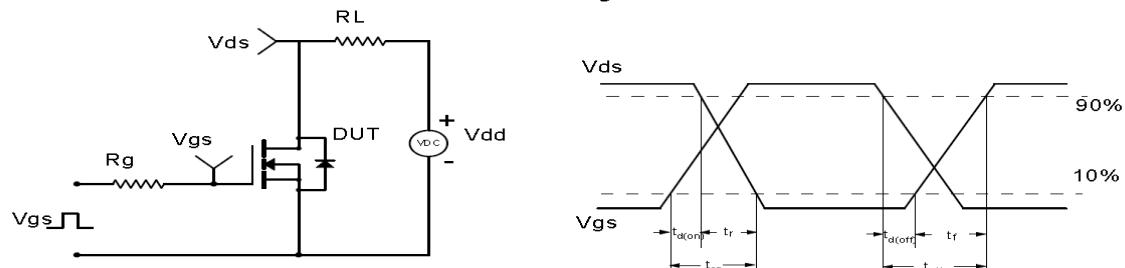
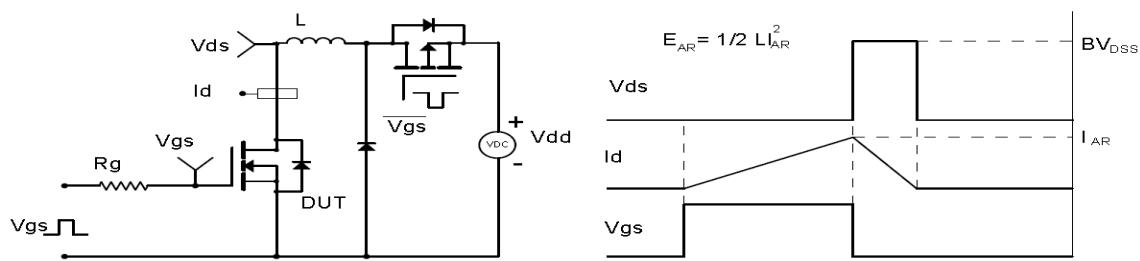
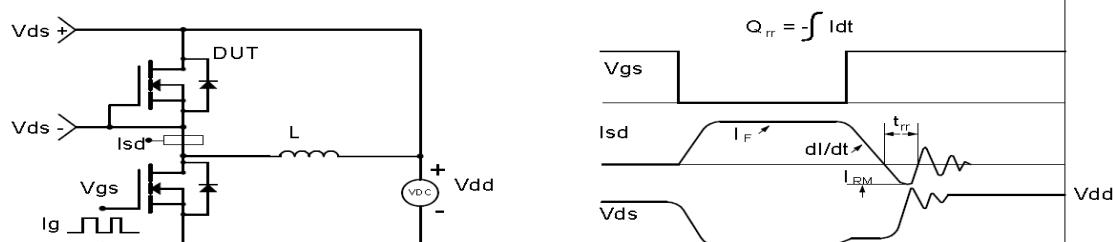
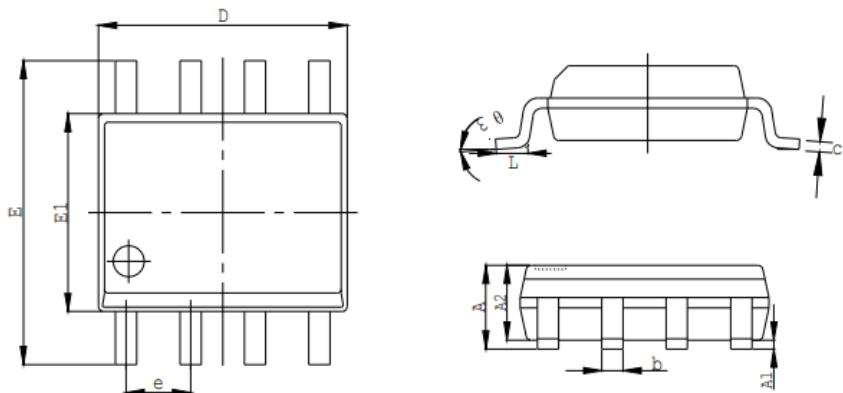
Fig 7: BV_{dss} vs. Temperature

Fig 8: Body-diode Forward Characteristics

Fig 9: Gate Charge Characteristics

Fig 10: Capacitance Characteristics

Fig 11: Drain Current Derating

Fig 12: Power Dissipation


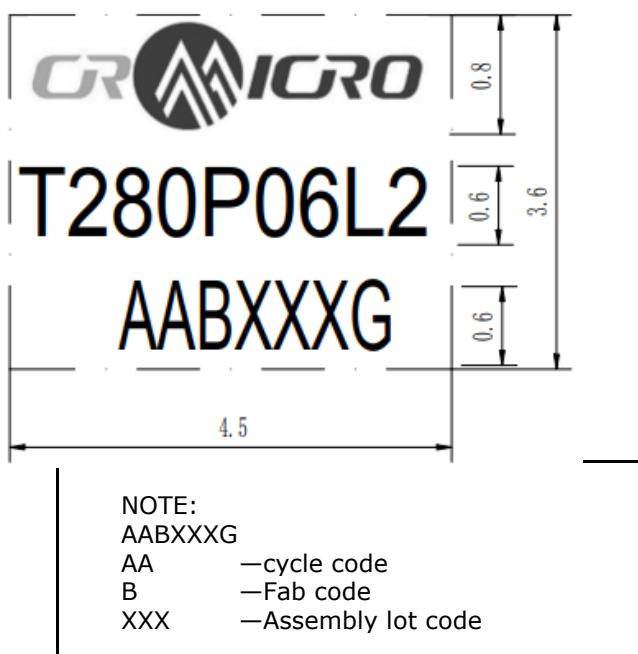
Fig 13: Safe Operating Area

Fig 14: Max. Transient Thermal Impedance


Test Circuit & Waveform

Gate Charge Test Circuit & Waveform

Resistive Switching Test Circuit & Waveforms

Unclamped Inductive Switching (UIS) Test Circuit & Waveforms

Diode Recovery Test Circuit & Waveforms


Package Outline: SOP8


Symbol	values(mm)	
	Min.	Max.
A	1.30	1.80
A1	0.10	0.25
A2	1.30	1.50
E	5.80	6.20
E1	3.80	4.00
D	4.80	5.00
L	0.40	0.90
e	1.27TYP	
b	0.37	0.47
c	0.20TYP	
θ3	0°	8°

Marking


**Revision History**

Revison	Date	Major changes
1.0	2023/10/9	Relaease of formal version
2.0		
3.0		

Disclaimer

Unless otherwise specified in the datasheet, the product is designed and qualified as a standard commercial product and is not intended for use in applications that require extraordinary levels of quality and reliability, such as automotive, aviation/aerospace and life-support devices or systems.

Any and all semiconductor products have certain probability to fail or malfunction, which may result in personal injury, death or property damage. Customer are solely responsible for providing adequate safe measures when design their systems.

CRM reserves the right to improve product design, function and reliability without notice.